

Reliability Monitoring Results

Quarters: Q1/2024 to Q4/2024

Based on structural similarity

Supplier		User Part Number				
Nexperia B.V.		HEF4521BT				
Part Description: 24-stage frequency divider and oscillator						
Function Family: HEF4000B Process family: Super micron Package family: SO						
JESD47 Test	Test Conditions	Duration	# Lots	# Quantity	# Rejects	
# 1 TEST Pre- and Post-Stress Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below	
# 2 PC Preconditioning	JESD22-A113 MSL 1	N/A	479	30634	0	
# 5a HTOL EFR High Temperature Operating Life Extrinsic	JESD22-A108 Tj = 150°C VCCMAX ≤ V ≤ 1.2*VCCMAX	48 hours or 168 hours	70	14662	0	
# 5b HTOL IFR High Temperature Operating Life Intrinsic	JESD22-A108 Tj = 150°C VCCMAX ≤ V ≤ 1.2*VCCMAX	≥500 hours	70	3592	0	
# 7 TC Temperature Cycling	JESD22-A104 -65 °C to 150°C	≥500 cycles	78	18207	4	
# 9 uHAST / HAST unbiased or biased High Accelerated Stress Test	JESD22-A101 Tamb = 130 °C, RH = 85%, V = VCCMAX	96 hours	212	12427	0	

Calculation of PPM, FIT and MTTF

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above)

Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic (HTOL IFR, Test # 5b above)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Product Family	Package Family	Quantity	Rejects	Extrinsic Failure Rate (PPM)	Intrinsic Failure Rate (FIT)	MTTF (hrs)
HEF4000B	SO	3592	0	63	1	1.04 E+09